

Substitute Form PTO-1449 (Modified)  <b>Information Disclosure Statement by Applicant</b> (Use several sheets if necessary)  (37 CFR §1.98(b))	U.S. Department of Commerce Patent and Trademark Office	Attorney Docket No. <b>20228-0013US1</b>	Application No. <b>10/580,698</b>
	Applicant <b>Damian Fiolka et al.</b>		
	Filing Date <b>November 29, 2006</b>	Group Art Unit <b>2872</b>	

U.S. Patent Documents							
Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
	1	4,744,615	5/17/1988	Fan et al.			
	2	5,345,292	9/6/1994	Shiozawa et al.			
	3	5,365,371	11/15/1994	Kamon			
	4	5,541,026	7/30/1996	Matsumoto			
	5	5,559,583	9/24/1996	Tanabe			
	6	5,621,498	4/15/1997	Inoue et al.			
	7	5,627,626	5/6/1997	Inoue et al.			
	8	5,663,785	9/2/1997	Kirk et al.			
	9	5,707,501	1/13/1998	Inoue et al.			
	10	5,739,898	4/14/1998	Ozawa et al.			
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	13	6,211,944	4/3/2001	Shiraishi			
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	16	6,259,512	7/10/2001	Mizouchi			
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	18	6,404,482	6/11/2002	Shiraishi			
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	20	6,535,273	3/18/2003	Maul			
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	22	6,583,931	6/24/2003	Hiraiwa et al.			
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	26	6,856,379	2/15/2005	Schuster			
	27	6,913,373	7/5/2005	Tanaka et al.			

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	32	2002/0085176	7/4/2002	Hiraiwa et al.			
	33	2002/0085276	7/4/2002	Tanitsu et al.			
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	36	2002/0176166	11/28/2002	Schuster			
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	41	2003/0007158	1/9/2003	Hill			
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	51	2006/0072095	4/6/2006	Kudo et al.			
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	53	2006/0139611	6/29/2006	Wagner et al.			
	54	2006/0146384	7/6/2006	Schultz et al.			

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	56	2007/0008511	1/11/2007	DeBoeij et al.			
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Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation	
							Yes	No
	73	WO 99/49504	9/30/1999	WIPO			Abstract only	
	74	WO 00/02092	1/13/2000	WIPO			Abstract only	
	75	WO 00/67303	11/9/2000	WIPO			Abstract only	
	76	WO 02/082169	10/17/2002	WIPO				
	77	WO 02/093209	11/21/2002	WIPO			Abstract only	

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							Yes	No
	78	WO 04/051717	6/17/2004	WIPO			Abstract only	
	79	WO 05/031467	4/7/2005	WIPO				
	80	WO 05/036619	4/21/2005	WIPO			Abstract only	
	81	WO 05/041277	5/6/2005	WIPO			Abstract only	
	82	WO 05/069081	7/28/2005	WIPO				
	83	EP 0 764 858	8/30/1996	EP			Abstract only	
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	85	JP 62-265722	11/18/1987	Japan			Abstract only	
	86	JP 04-101148	4/2/1992	Japan			Abstract only	
	87	JP 04-225357	8/14/1992	Japan			Abstract only	
	88	JP 05-109601	4/30/1993	Japan			English Abstract and Translation	
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	97	JP 09-219358	8/19/1997	Japan			English Abstract and Translation	
	98	JP 10-303114	11/13/1998	Japan			English Abstract and Translation	
	99	JP 10-104427	4/24/1998	Japan			English Abstract and Translation	
	100	JP 11-54426	2/26/1999	Japan			English Abstract and Translation	
	101	JP 2000-114157	4/21/2000	Japan			English Abstract and Translation	
	102	JP 2001-274083	10/5/2001	Japan			English Abstract and Translation	
	103	JP 32-46615	11/2/2001	Japan			English Abstract and Translation	
	104	JP 2002-75835	3/15/202	Japan			English Abstract and Translation	
	105	JP 2002-075816	3/15/2002	Japan			English Abstract and Translation	
	106	JP 2002-231619	8/16/2002	Japan			English Abstract and Translation	
	107	JP 2002-324743	11/8/2002	Japan			English Abstract and Translation	
	108	JP 2002 334836	11/22/2002	Japan			English Abstract and Translation	
	109	JP 2003-35822	2/7/2003	Japan			English Abstract and Translation	

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	110	JP 2003-059821	2/28/2003	Japan			English Abstract and Translation	
	111	JP 2003 297727	10/17/2003	Japan			English Abstract and Translation	
	112	JP 2004-179172	6/24/2004	Japan			English Abstract and Translation	

Other Documents (include Author, Title, Date, and Place of Publication)		
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	113	Bruner et al., "High NA Lithographic Imaging at Brewster's Angle," SPIE (USA), Vol. 4691, pp.1-10, 2002
	114	Fused quartz, <a href="http://en.wikipedia.org/wiki/Fused_quartz">http://en.wikipedia.org/wiki/Fused_quartz</a> , August 27, 2009
	115	Copy of International Search Report for International Application No. PCT/EP05/050981, dated July 28, 2005.
	116	Copy of International Preliminary Report on Patentability for International Application No. PCT/EP05/050981, dated November 29, 2006
	117	Copy of EP office action, for the corresponding EP Application No. 05 706 888.4, dated March 3, 2008
	118	Copy of Chinese Office Action with English translation for the corresponding Chinese Application No. 200580002241.9, filed January 14, 2005, dated December 5, 2008
	119	Copy of Chinese Office Action with English translation, for the corresponding Chinese Application No. 200580002241.9, filed January 14, 2005, dated May 9, 2008
	120	Copy of the International Preliminary Report on Patentability for the corresponding PCT application PCT/EP2005/000320, filed January 14, 2005

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